

# Status Report of the Prototype Development of a GEM-TPC for the SuperFRS



## COLLABORATORS

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# OUTLINE

- Introduction and Motivation
- GEM Technology and Characterization
- First GEM-TPC Prototype HB1 - Tests
- Status of the Prototype HB2 - AFTER and Prototype HB3 - Xyter Readout electronics
- Tasks Schedule for 2011
- Todo

# INTRODUCTION

**FAIR** is Facility for Antiproton and Ion Research. The concept of the FAIR Facility aims for a multifaceted forefront science program, beams of stable and unstable nuclei as well as antiprotons in a wide range of intensities and energies, with optimum beam qualities



Time Table spans till end 2018

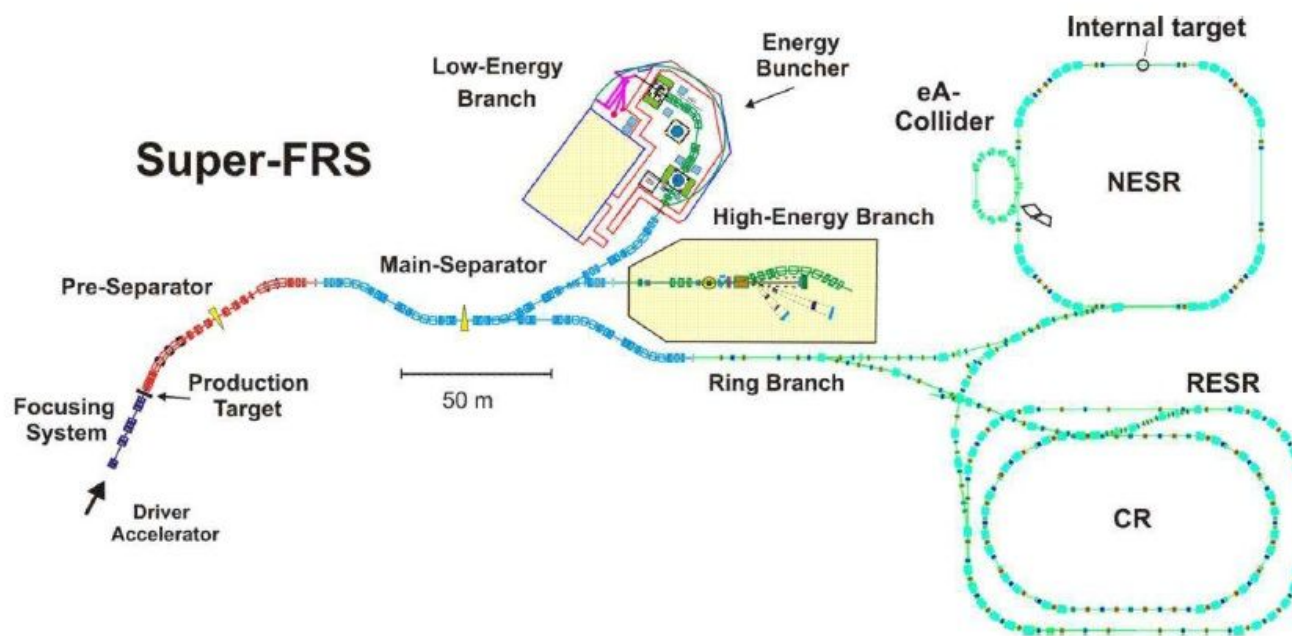
# MOTIVATION

*NUSTAR collaboration (Nuclear Structure, Astrophysics, and Reactions) has more than 700 members in total.*

*Part of the Finnish Contribution will be in the superconducting in-flight separator (Super-FRS)*

*Diagnostic systems, which is a work package dedicated to provide 36 GEM-TPC detectors*

The NUSTAR Facility at FAIR  
(The 3 Branches of the Super-FRS)

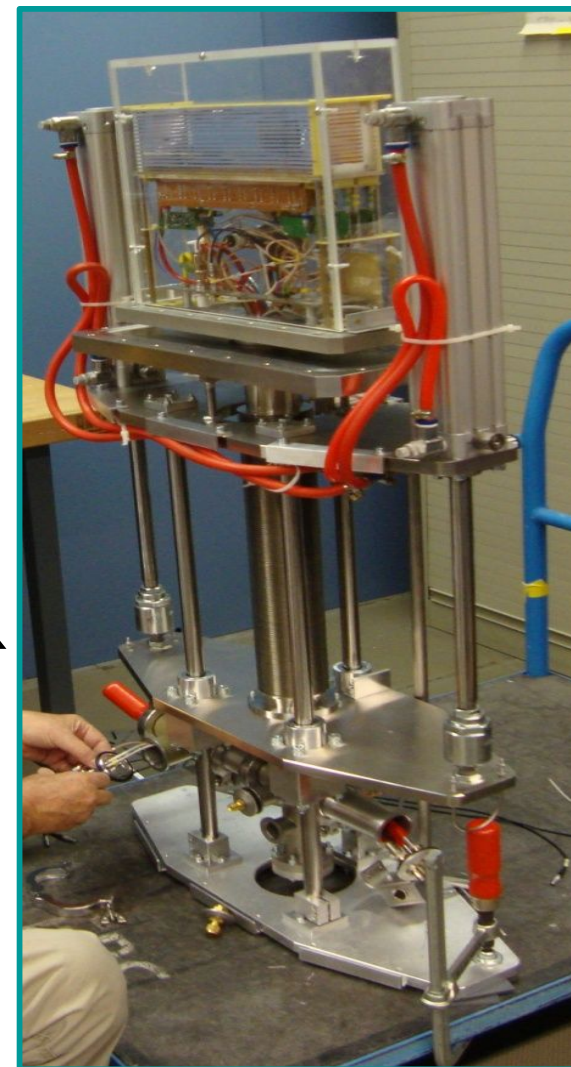
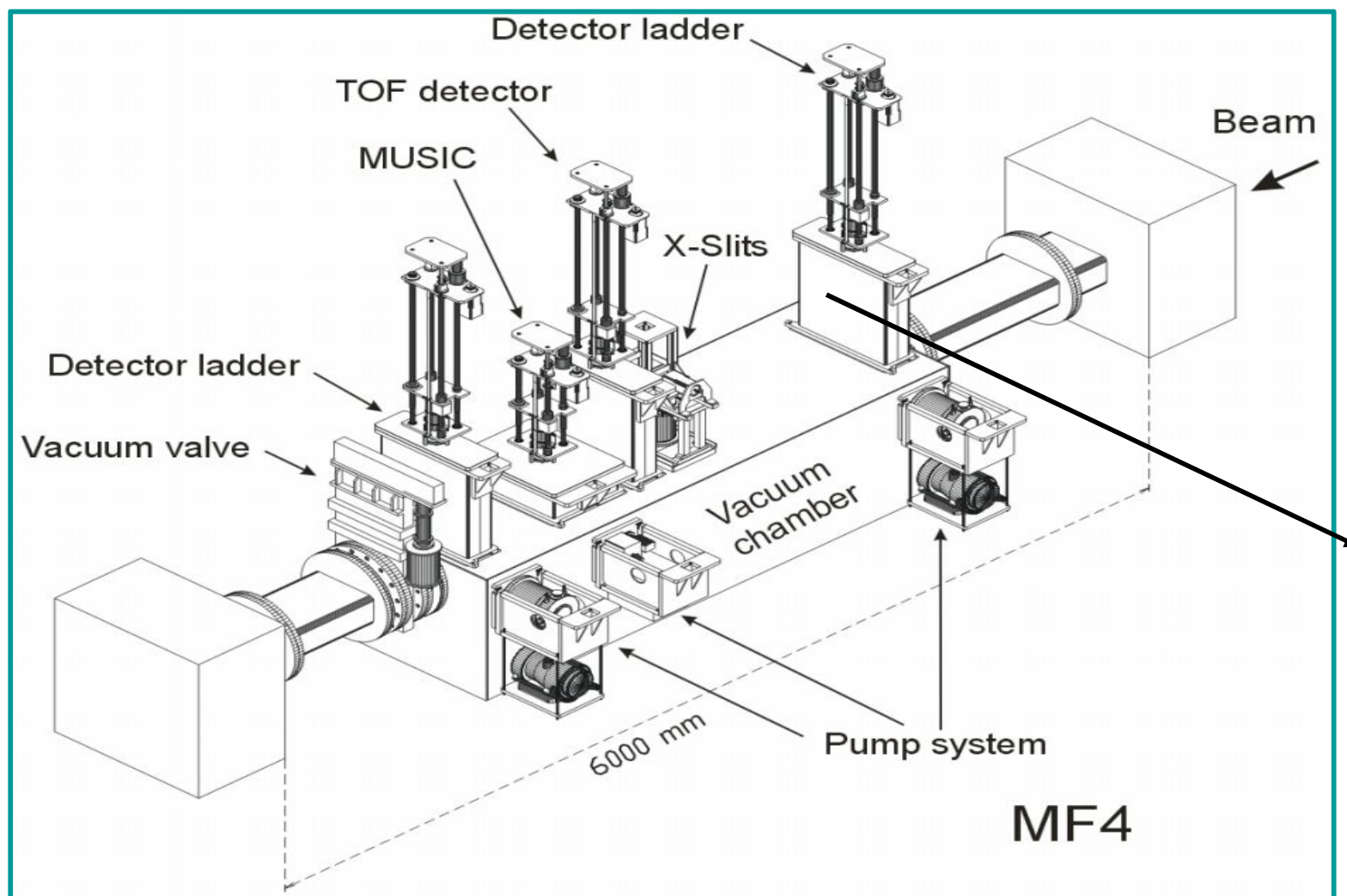


**NUSTAR** = Nuclear Structure, Astrophysics and Reactions



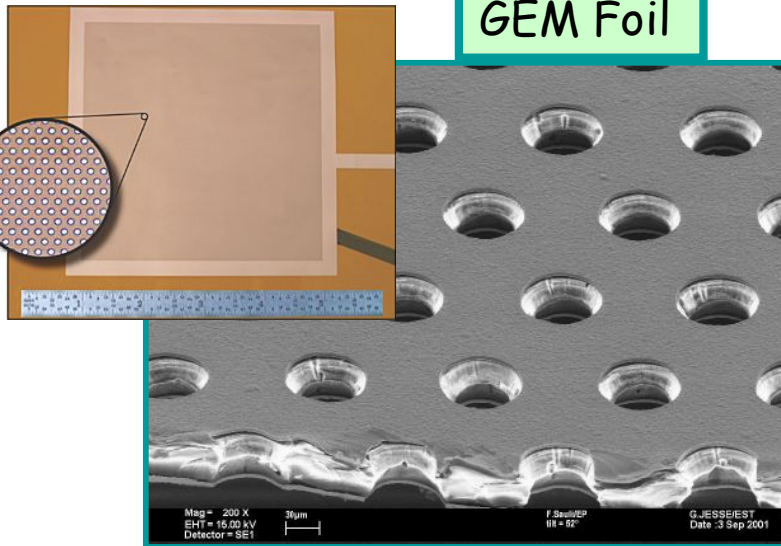
# MOTIVATION (cont.)

## DIAGNOSTIC SYSTEM STATION

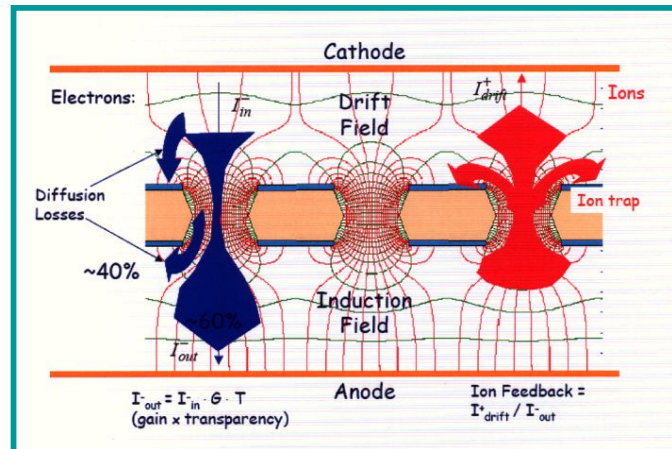


## GEM TECHNOLOGY and CHARACTERIZATION

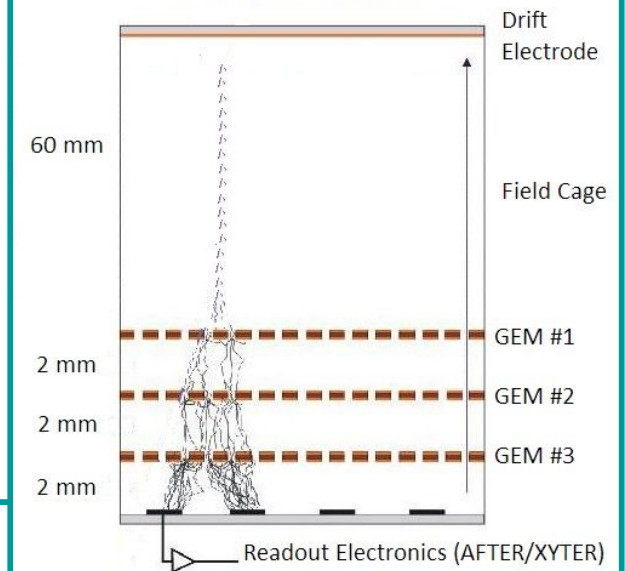
### GEM Foil



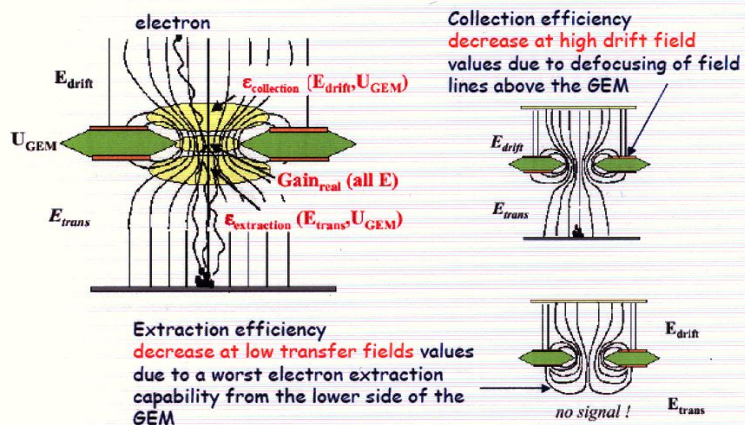
### GEM Operation Principle



### GEM-TPC LAYOUT

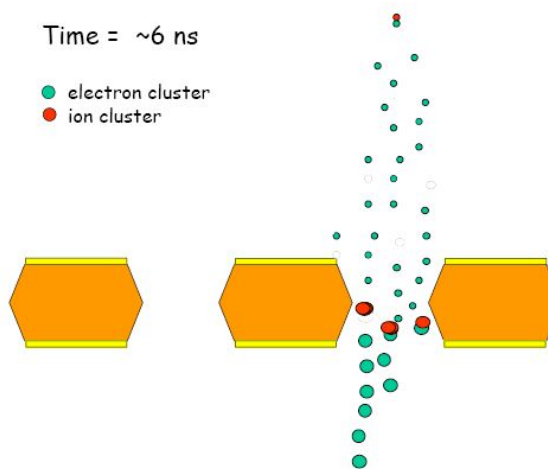


### Extraction of the Electron Cloud and Signal Induction



Time = ~6 ns

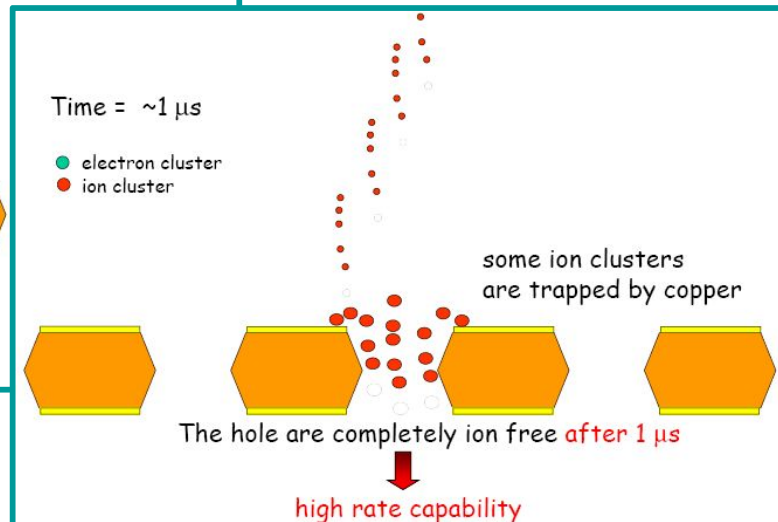
- electron cluster
- ion cluster



### Avalanche development in time domain

Time = ~1 μs

- electron cluster
- ion cluster

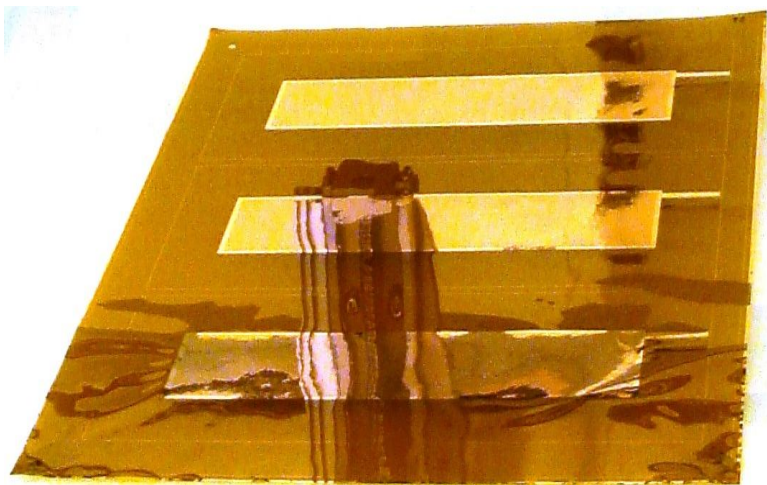
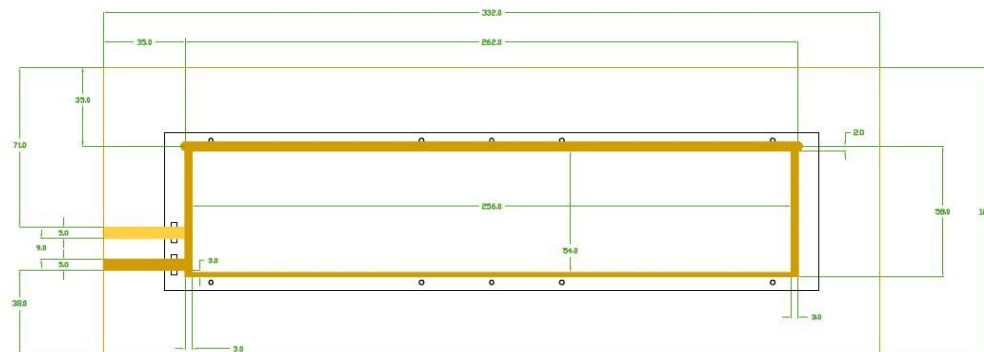




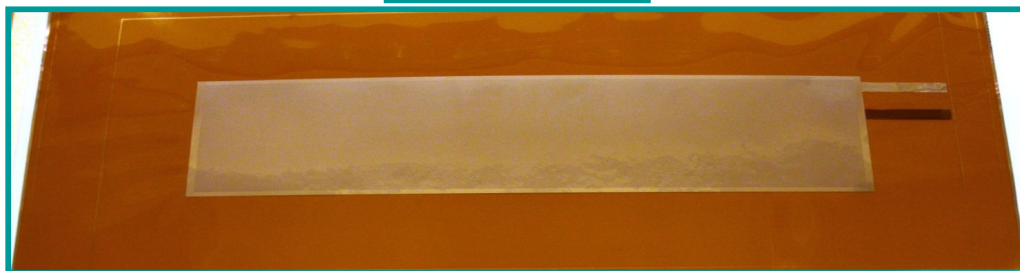
## GEM TECHNOLOGY and CHARACTERIZATION (cont.)

GEM mask designed at HIP and manufacture at CERN - workshop (Rui de Oliveira)

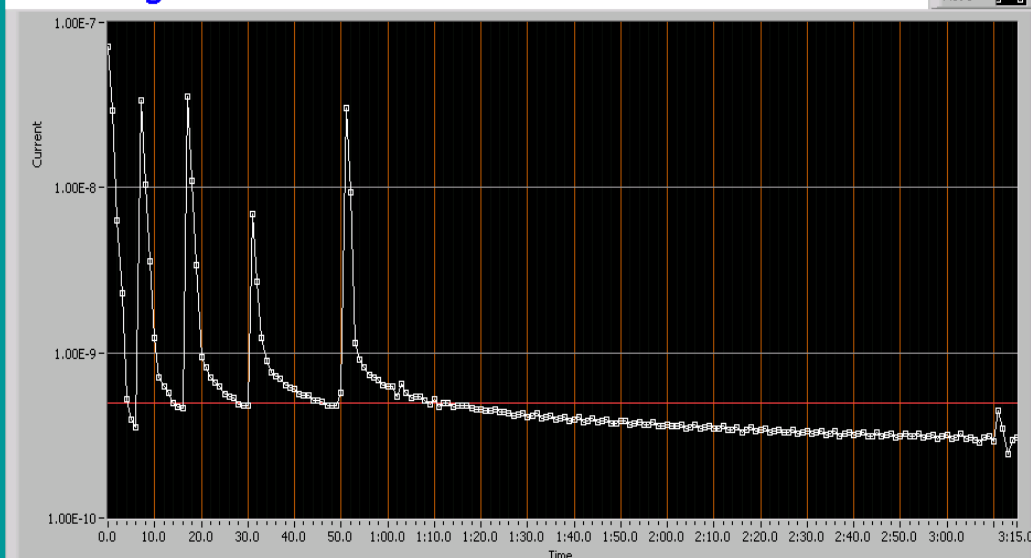
First GEM mask



GEM Foil



Leakage current



The leakage current well below the accepted limit of 0.5 nA during 30 min in  $N_2$

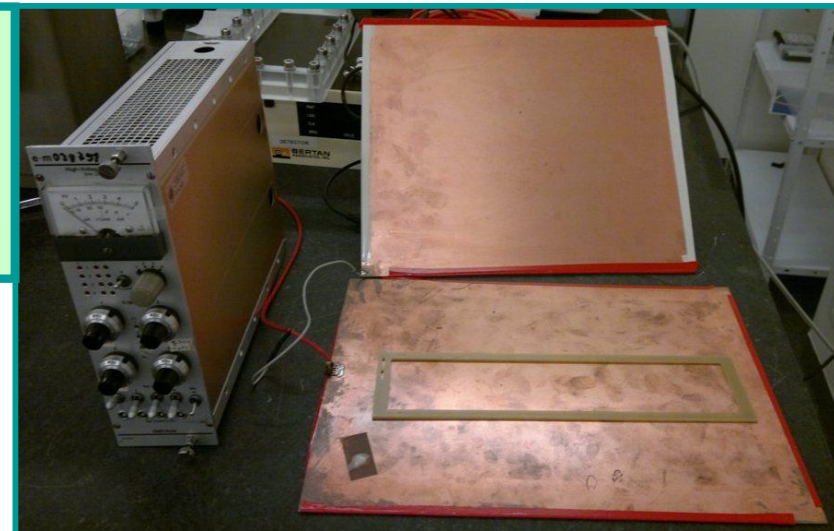
## GEM TECHNOLOGY and CHARACTERIZATION (cont.)

Top Frame

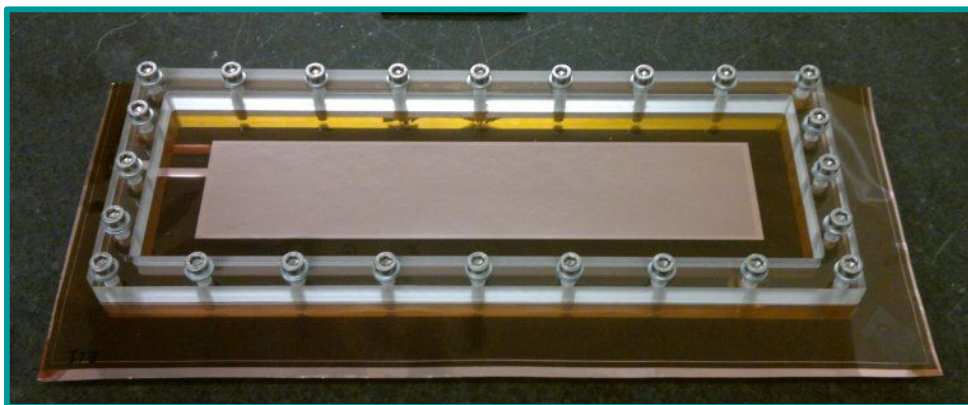
First mechanical models for the top and Bottom frames

Bottom Frame

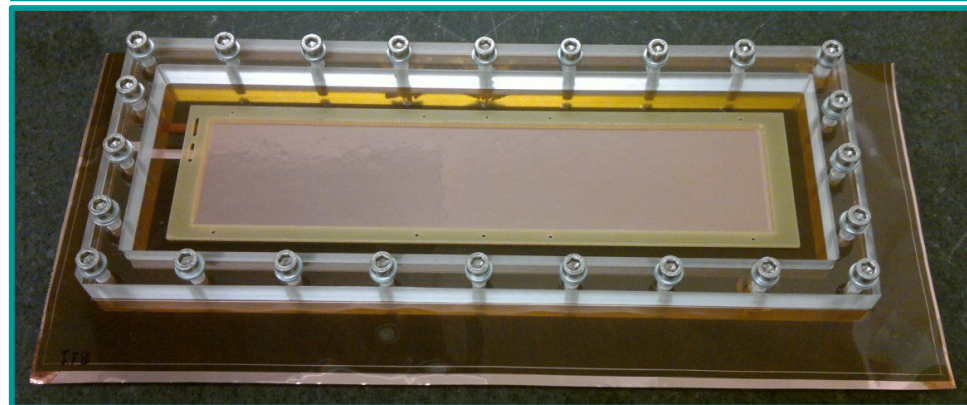
Electrostatic Test for all the frames @ 3 kV  
Possible breakdowns corrected with Nuvovern



GEM Foils stretcher - No repels or undulation visible



Top frame glued to the GEM foil, after cured in oven

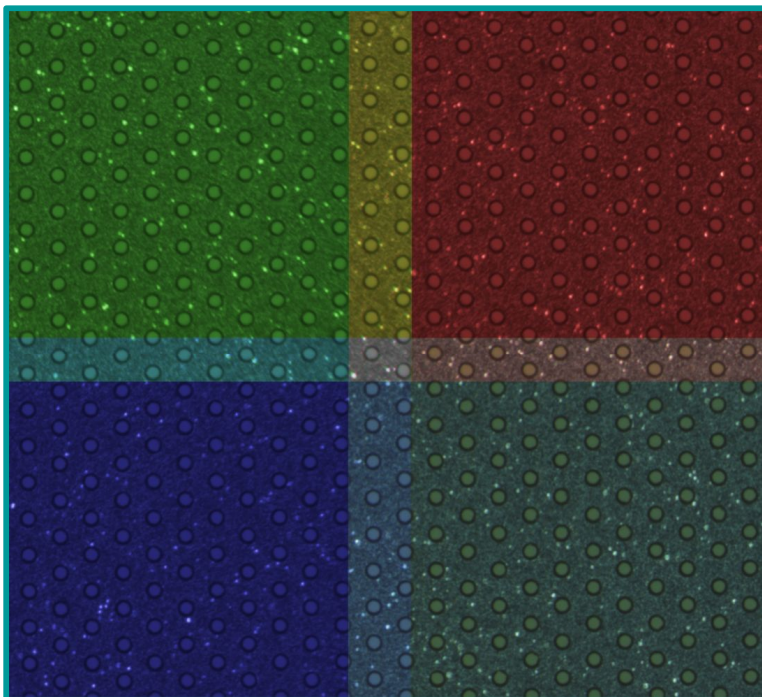




## GEM TECHNOLOGY and CHARACTERIZATION (cont.)

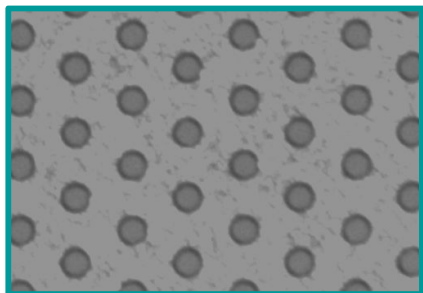
### FOUR images Stitched

The overlapping  
on these images  
is of  $245 \mu\text{m}$   
and  $140 \mu\text{m}$



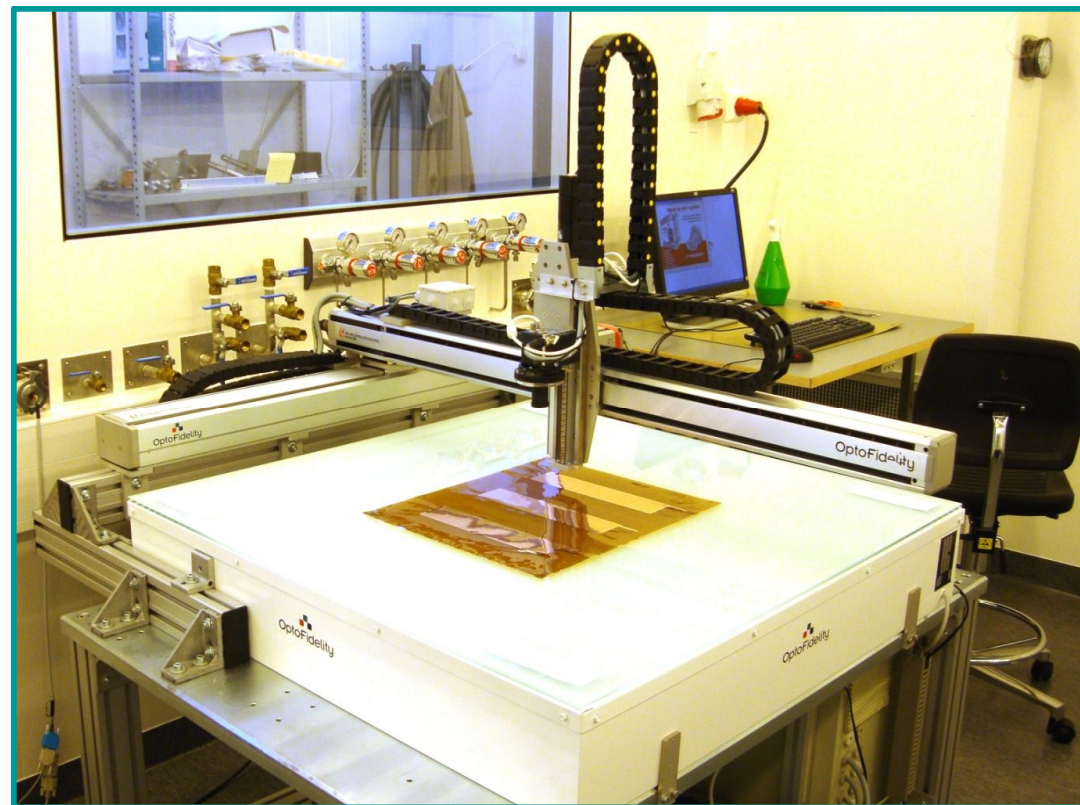
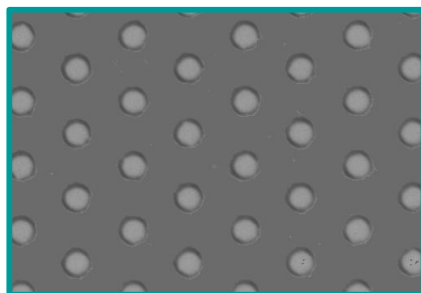
### After Apply Red Filter

This procedure is used to find  
defects and to find the outer  
diameter of the holes



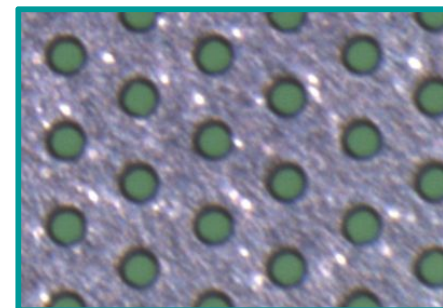
### After Apply Green Filter

This procedure is used to find  
blind holes and to measure the  
inner diameter of the holes



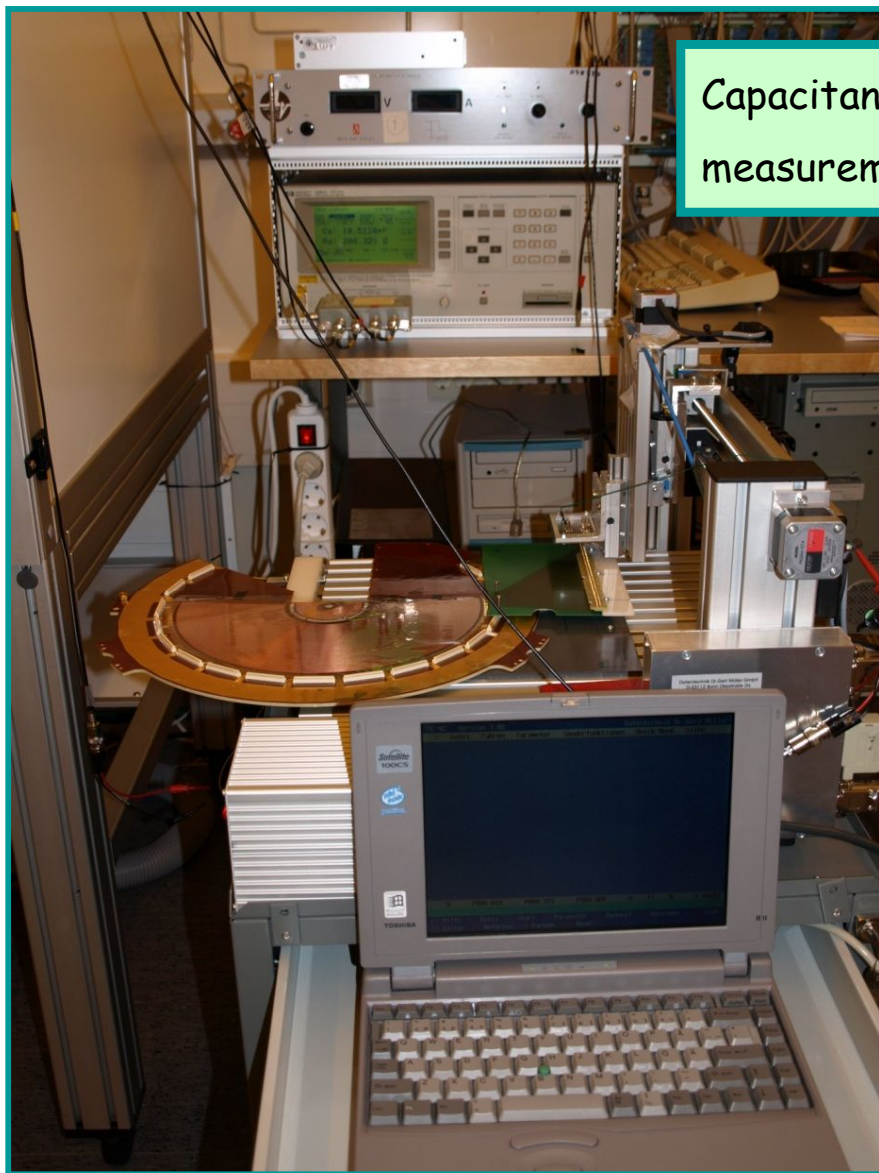
### New System

Based on 9 Mpix camera with  
integrated telecentric optics for  
this setup one pixel corresponds  
to  $1.7 \times 1.7 \mu\text{m}$

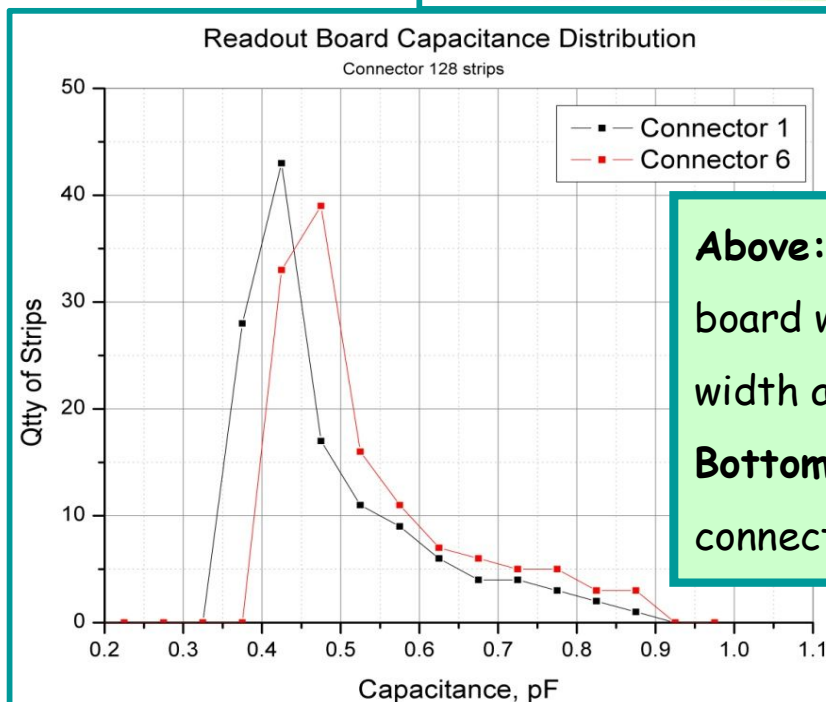
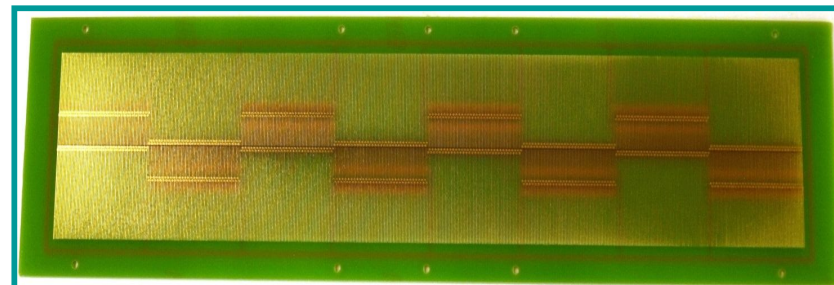




## GEM TECHNOLOGY and CHARACTERIZATION (cont.)

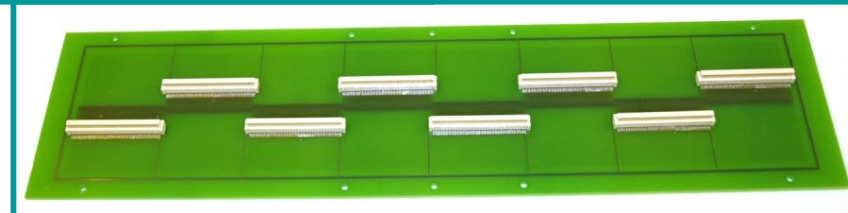


Capacitance  
measurement setup



**Above:** The electrodes of the board with strips of 200  $\mu\text{m}$  width and 500  $\mu\text{m}$  pitch

**Bottom:** 8 Header Panasonic connectors with 130 Pin each



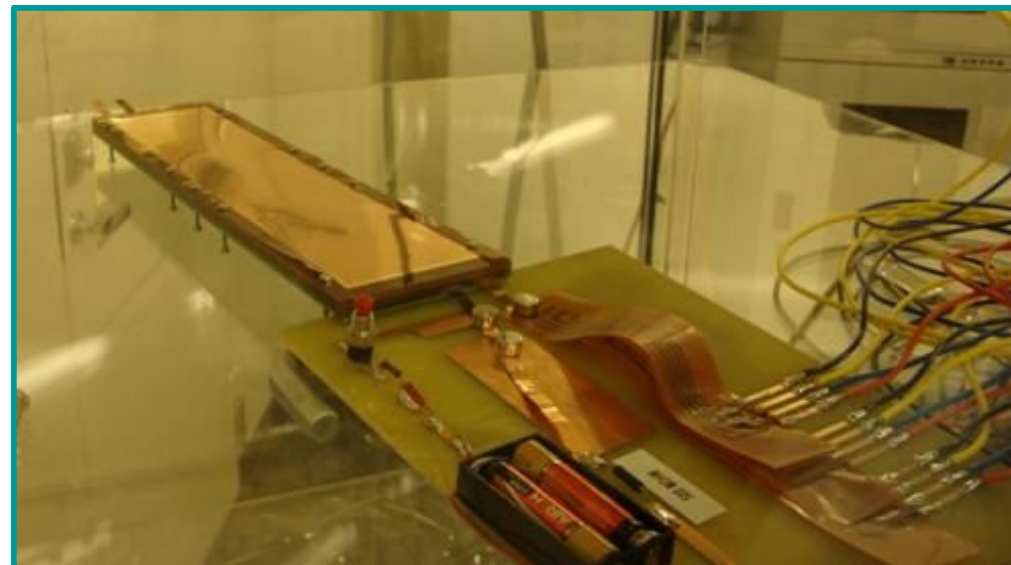
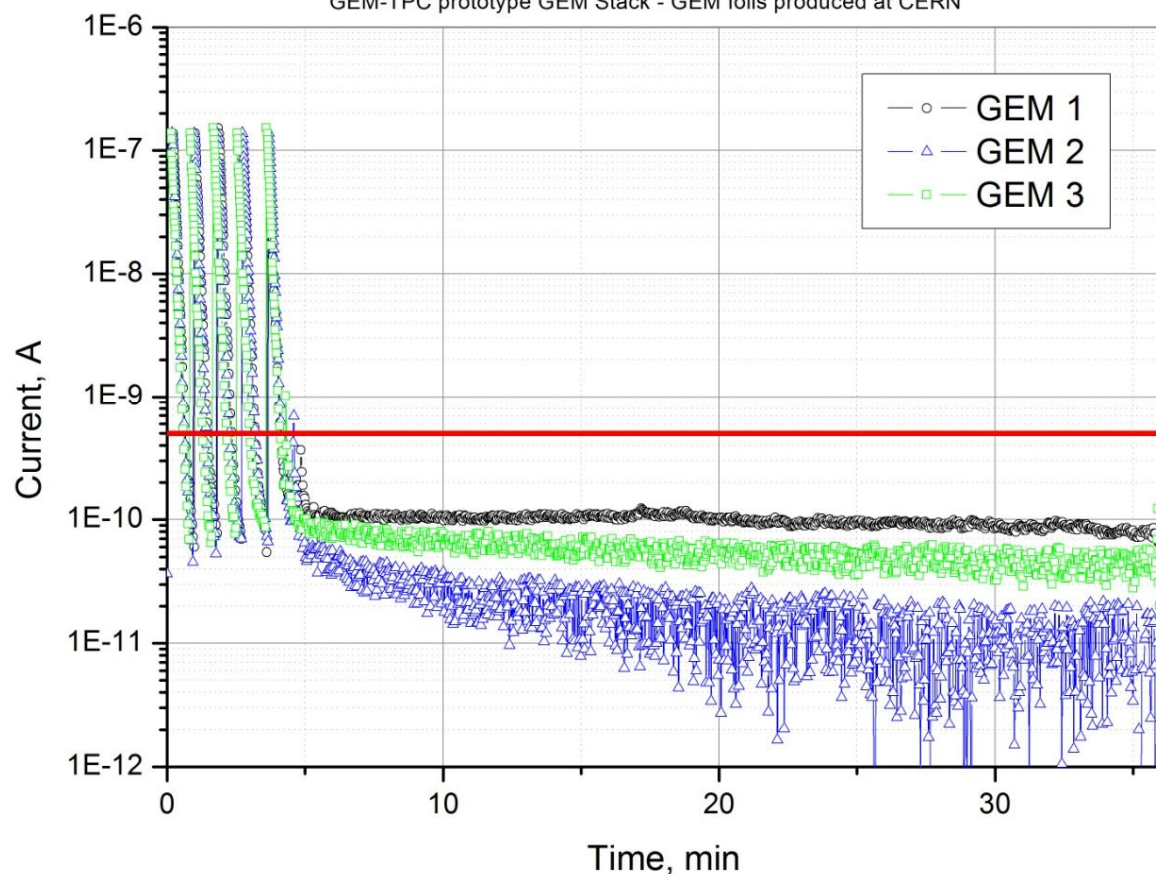
## GEM TECHNOLOGY and CHARACTERIZATION (cont.)

GEM Stack tests:

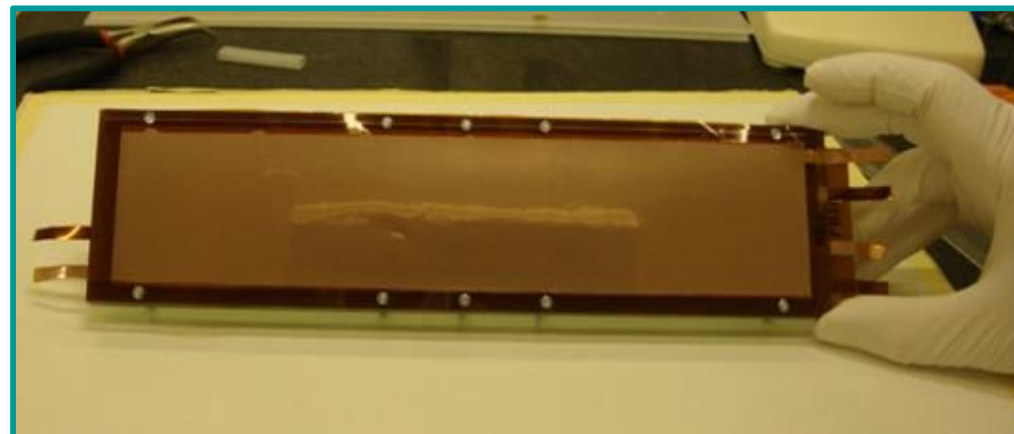
Triple GEM leakage current measurements

### Leakage Current Measurement

GEM-TPC prototype GEM Stack - GEM foils produced at CERN



GEM Stack for the GEM-TPC prototype HB2





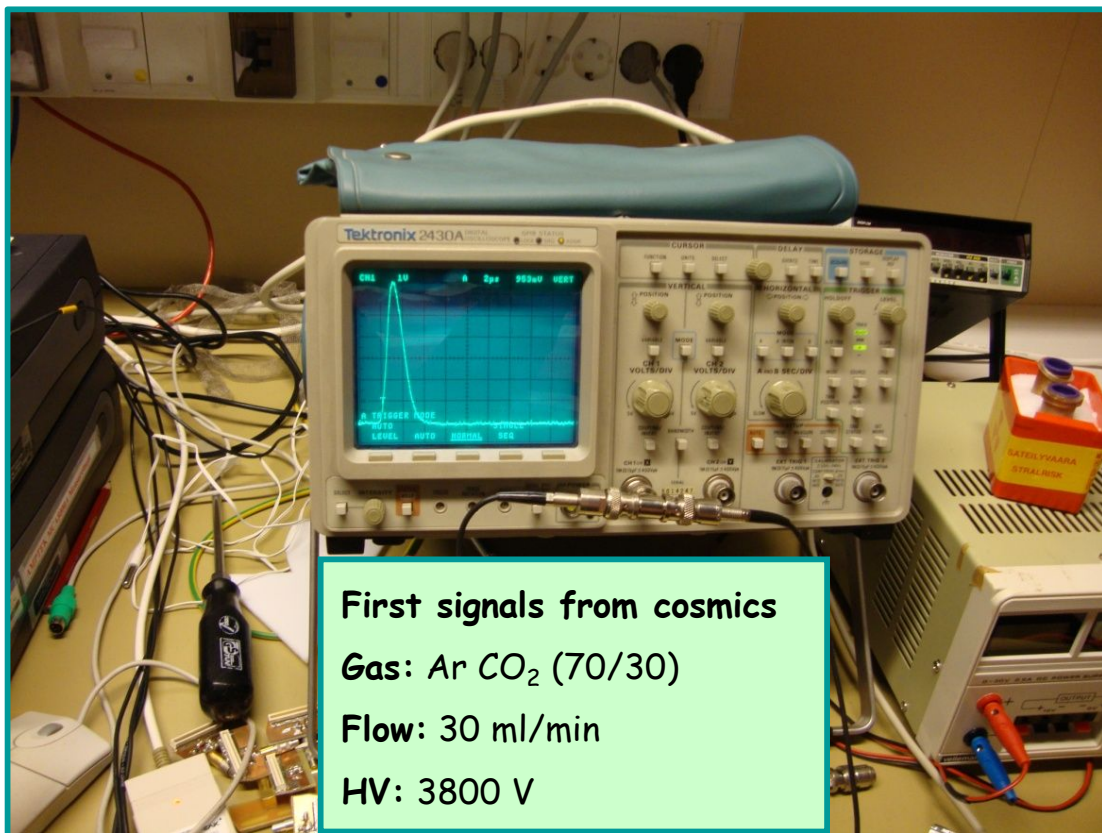
## GEM TECHNOLOGY and CHARACTERIZATION (cont.)

### GEM Stack tests:

Preliminary measurements in the lab; the radiation used for these tests was the  $^{55}\text{Fe}$  and cosmic

### GEM Stack test bench

The GEM stack was assembled as a triple GEM detector with 3 mm of Drift

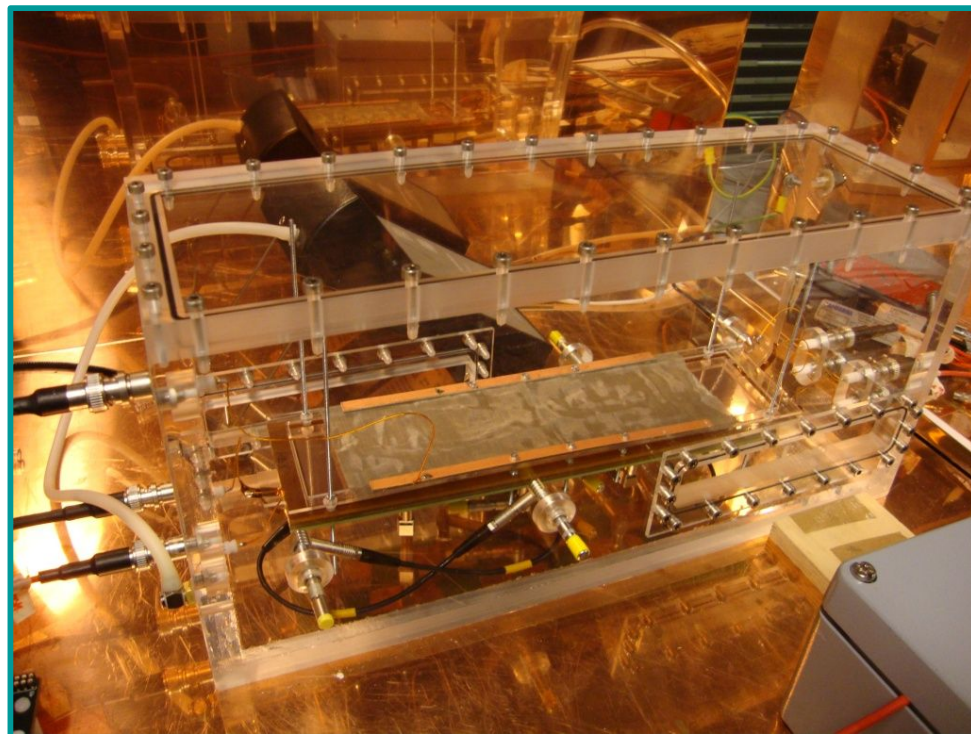


**First signals from cosmic**

**Gas: Ar CO<sub>2</sub> (70/30)**

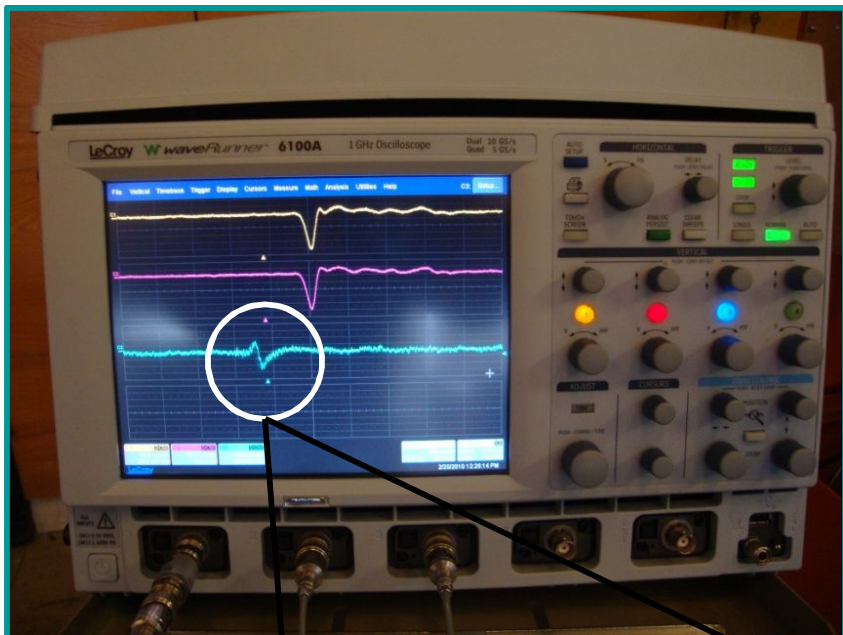
**Flow: 30 ml/min**

**HV: 3800 V**



# FIRST GEM-TPC PROTOTYPE HB1 - TEST

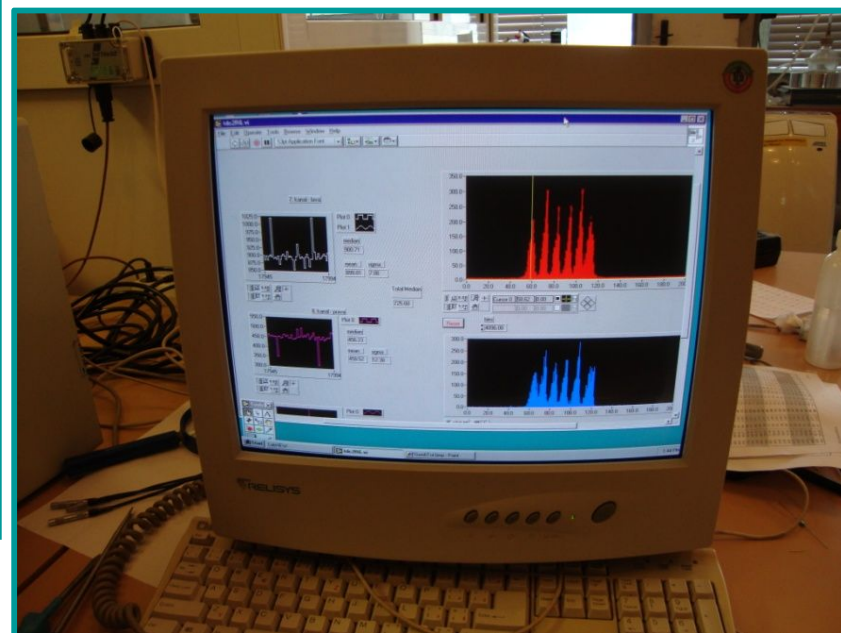
GEM-TPC test in lab at Comenius University



It can be observed:

- Signals from the delayed lines are very clean
- Same relative time between them
- Trigger signal bipolar, it can be that the 40% negative overshoot is due to e-transparency losses in the GEM 3

GEM-TPC tracking capabilities for  $^{55}\text{Fe}$



Trigger Signal before reshaping



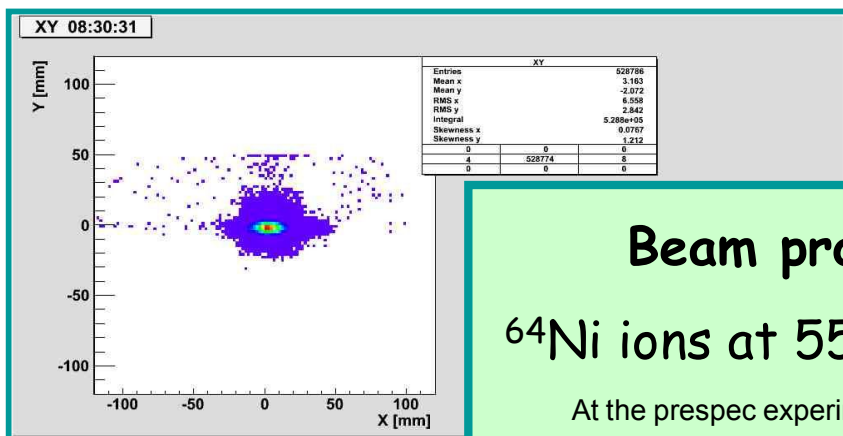
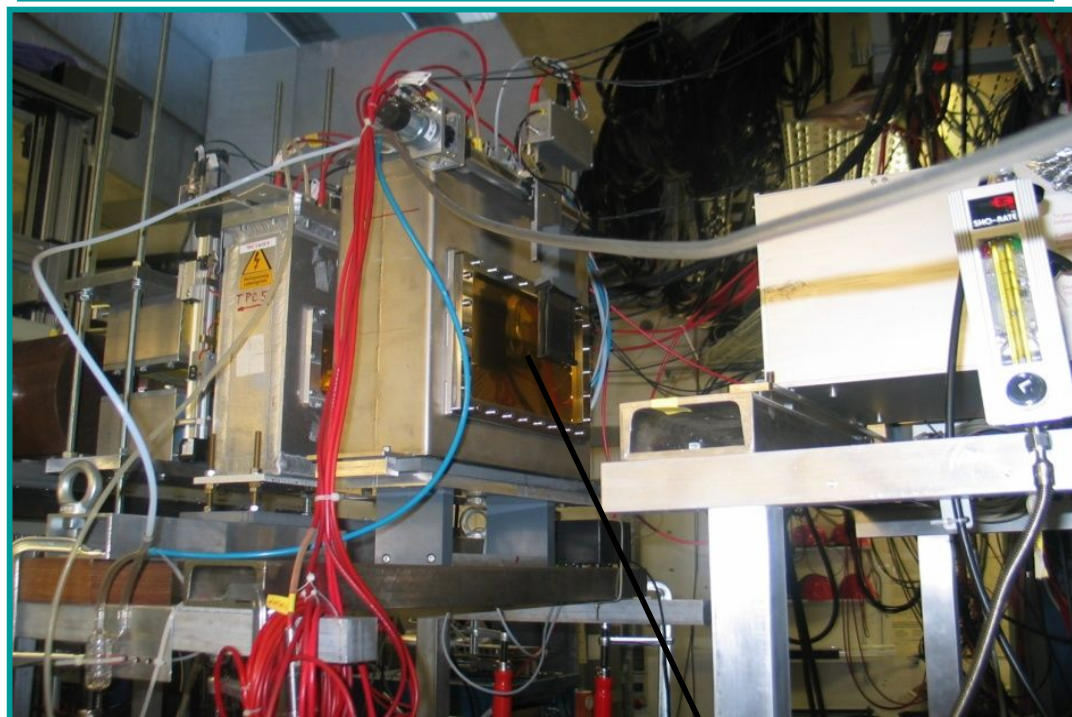
Trigger Signal with rise and decay time reshaped

In the picture above there are multiple picks from the different source positions. The source was not very well collimated therefore a mm scale resolution on X was achieved and the trigger was taken from the bottom of the GEM3

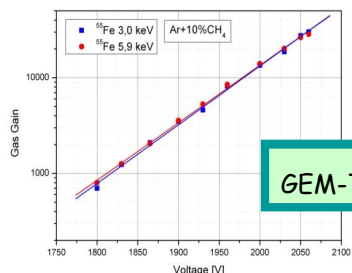


## FIRST GEM-TPC PROTOTYPE HB1 - TEST (cont.)

### GEM-TPC Beam test at GSI - Darmstadt

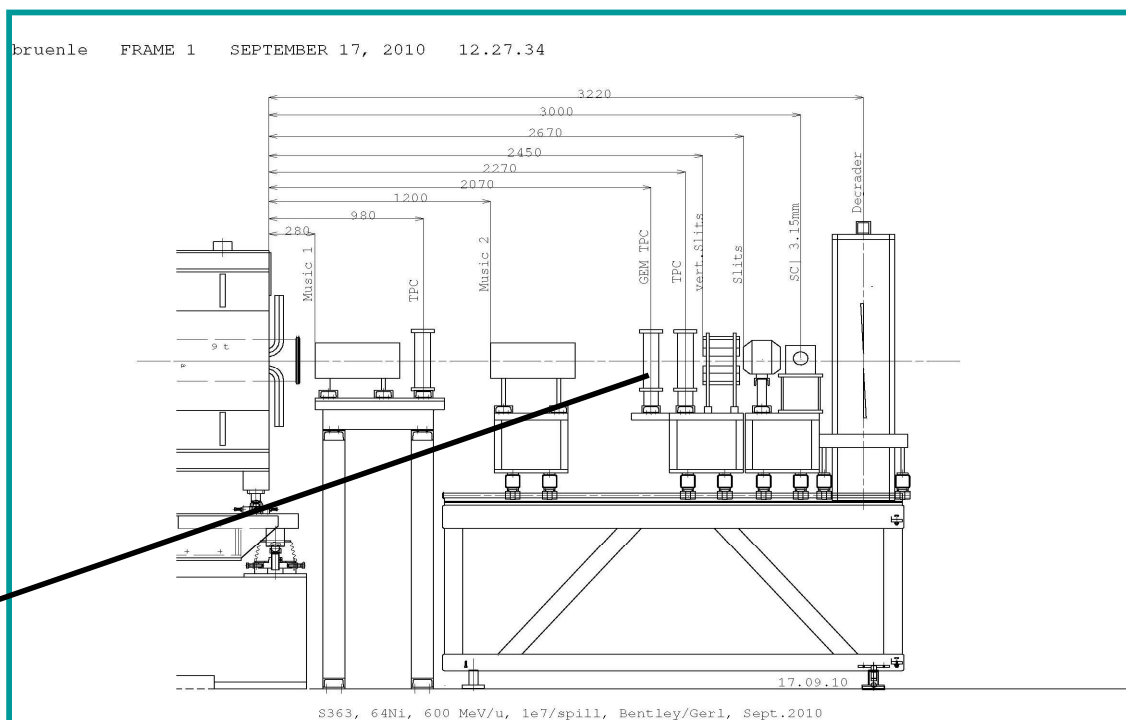


**Beam profile**  
 $^{64}\text{Ni}$  ions at 550 MeV/u  
 At the prespec experiment - S363



GEM-TPC Gain

GEM-TPC at S4

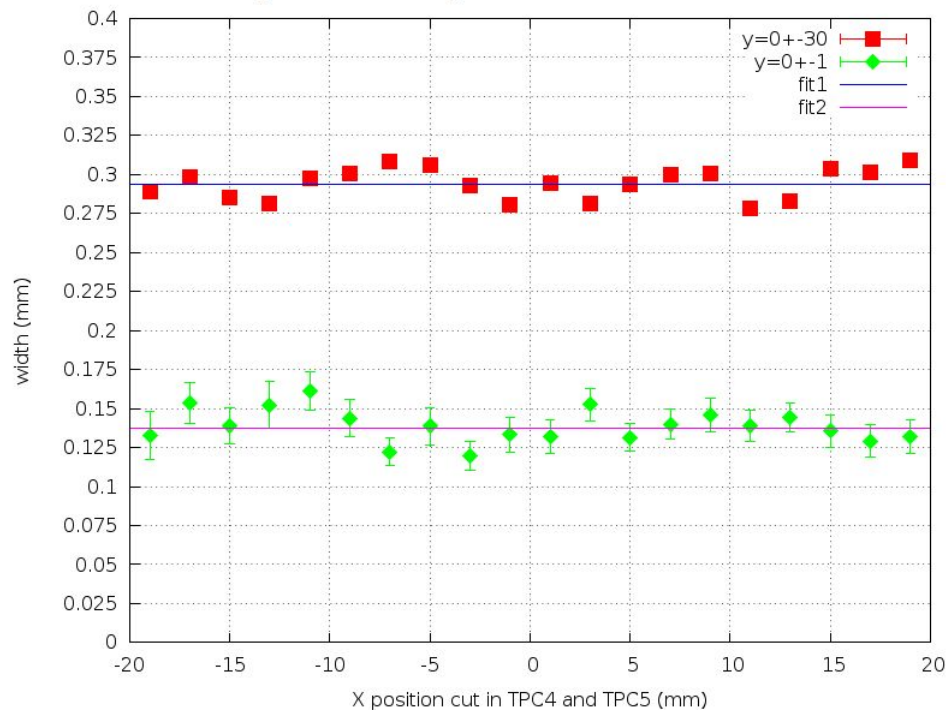




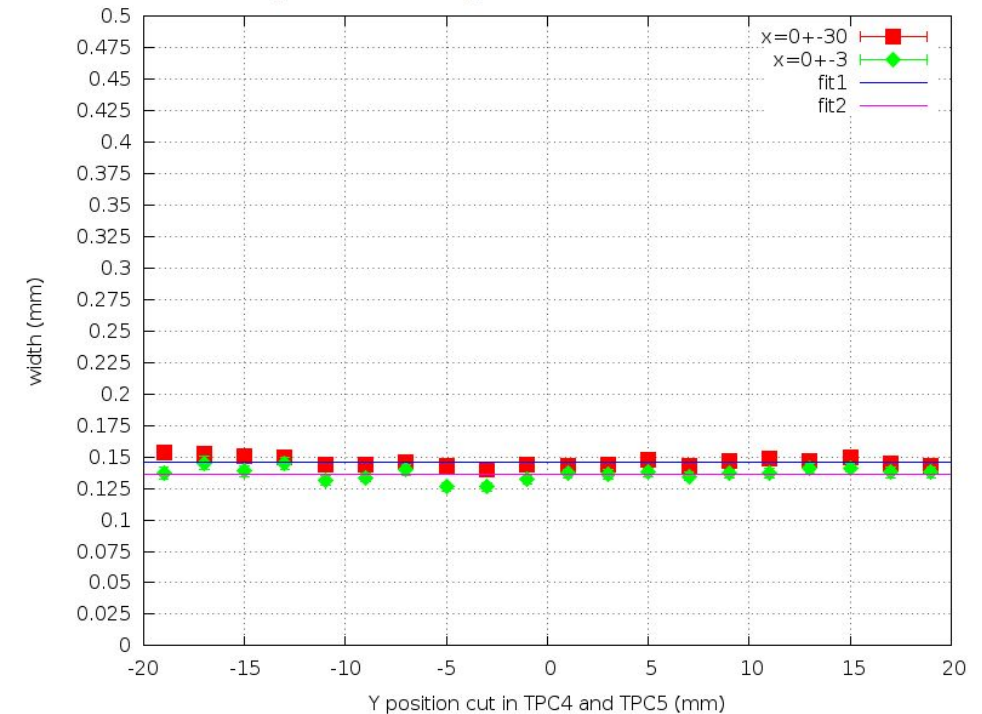
## FIRST GEM-TPC PROTOTYPE HB1- TEST (cont.)

### GEM-TPC Results for the Beam test @GSI

**GEM-TPC POSITION RESOLUTION**  
parallel strips + beam focused



**GEM-TPC POSITION RESOLUTION**  
parallel strips + beam focused



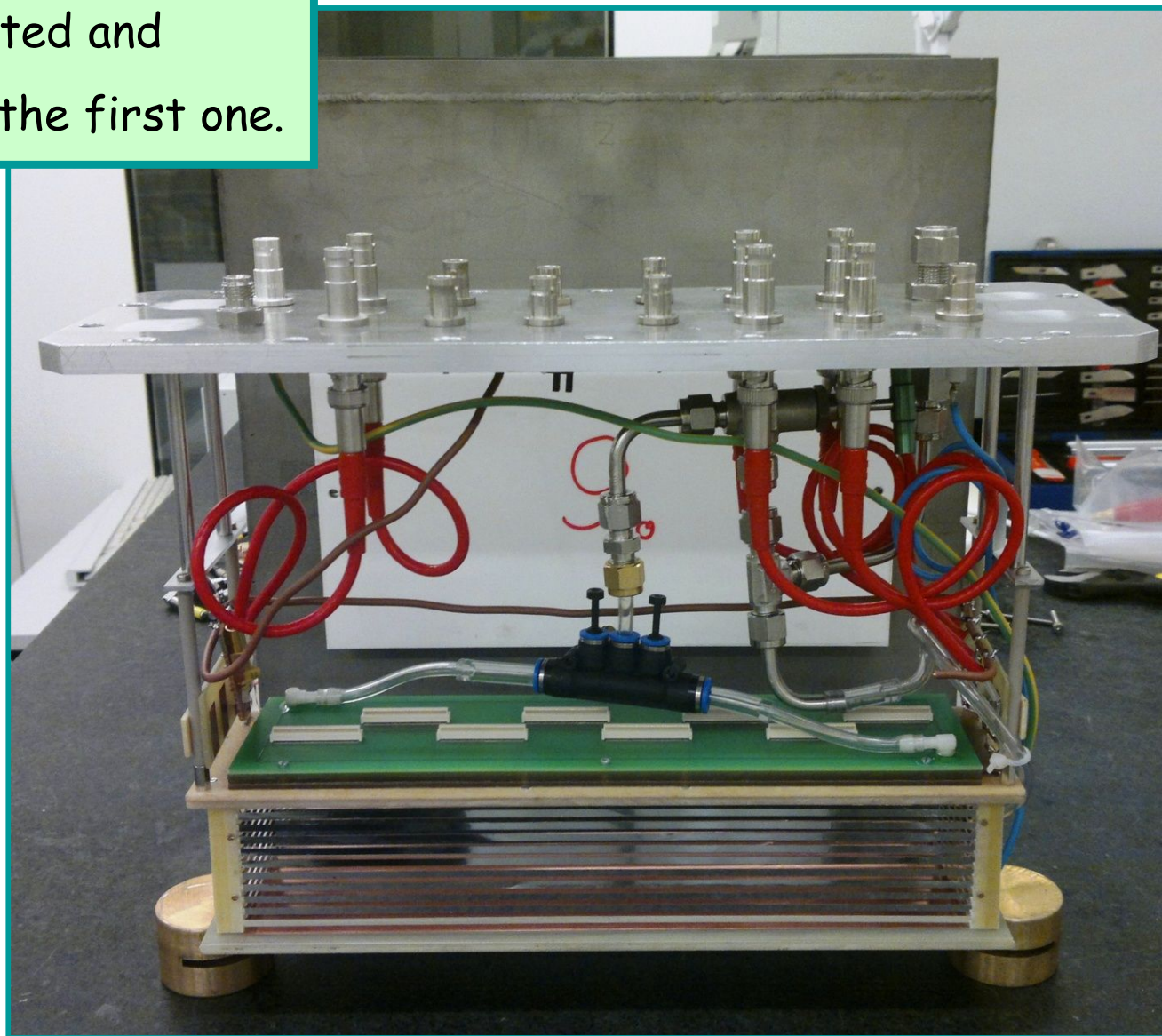
The GEM-TPC shows that the resolution in Y (Drift) reaches value around 130  $\mu\text{m}$  and on X between 130 to 300  $\mu\text{m}$

# STATUS OF THE PROTOTYPE HB2

The second GEM-TPC HB2 will be tested and characterized in a similar way as for the first one.

Test in the lab:

- ✓ Foils visual and scanned inspection
- ✓ Foils leakage current measurement
- ✓ Readout board capacitance measurement
- ✓ Energy resolution measurement
- ✓ Gain and its uniformity
- ✓ Oxygen concentration measurement
- ✓ Irradiation with  $^{55}\text{Fe}$



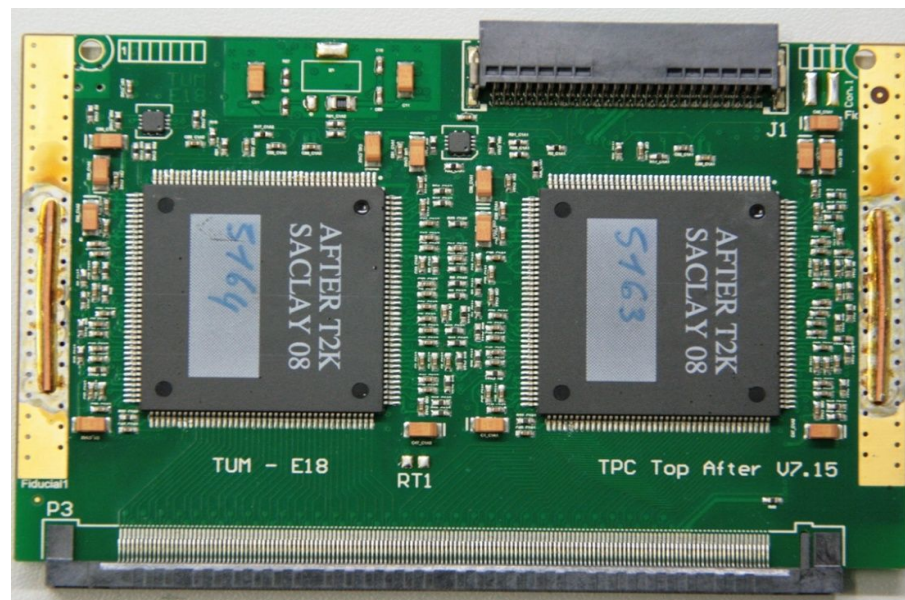


# SECOND GEM-TPC PROTOTYPE HB2 (cont.)

## GEM-TPC Readout Electronics and DAQ.

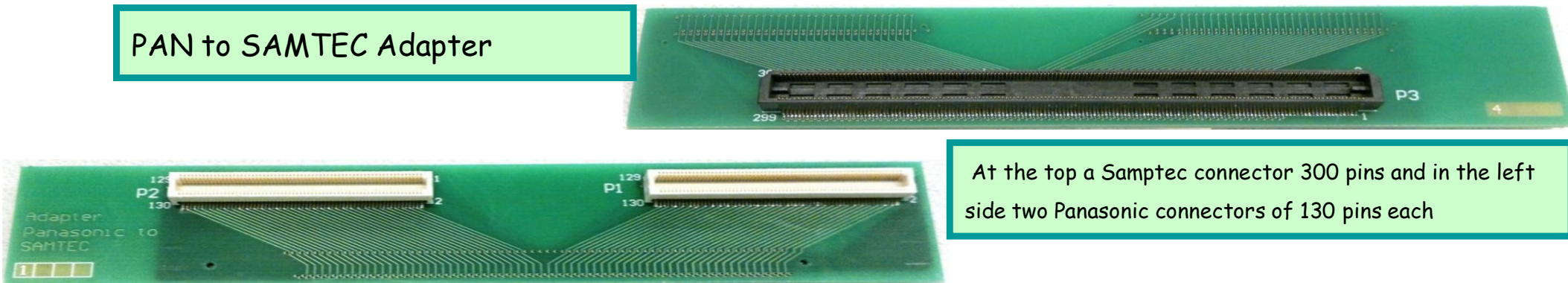
T2K FEC developed at TUM

4 AFTER chips for a total of 256 channels



GEM-TPC Readout board with 1024 strips cut in the middle

## PAN to SAMTEC Adapter



At the top a Samptec connector 300 pins and in the left side two Panasonic connectors of 130 pins each

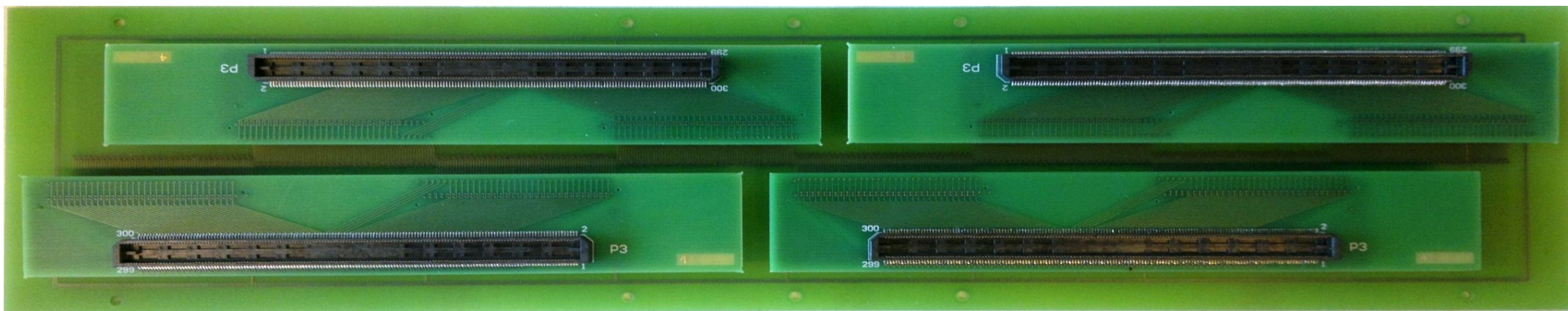
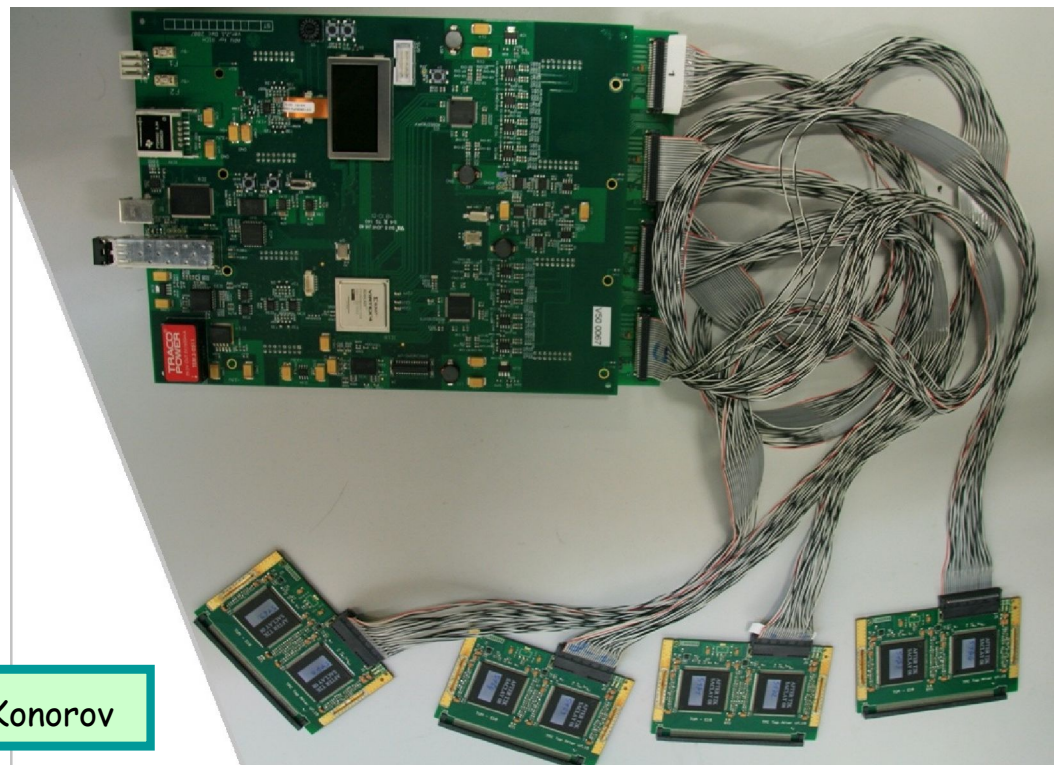


# SECOND GEM-TPC PROTOTYPE HB2 (cont.)

## GEM-TPC Readout Electronics and DAQ.

The trigger rate expected for the AFTER chip with  $\text{ArCO}_2$  and 60 mm drift is of about 6.4 kHz. Taken into account that a total of 60 cells are needed and the clock is at 45 MHz

Provide by Igor Konorov

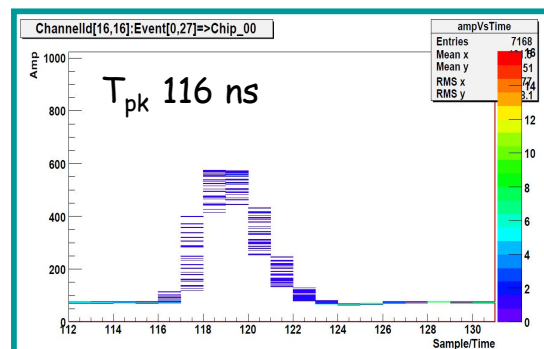


## SECOND GEM-TPC PROTOTYPE HB2 (cont.)

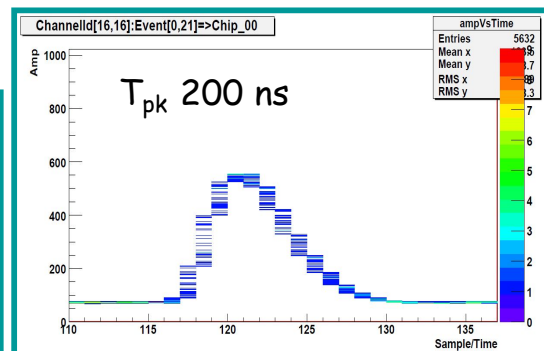
### GEM-TPC readout electronics performance

Presented by Igor Konorov  
at TUM

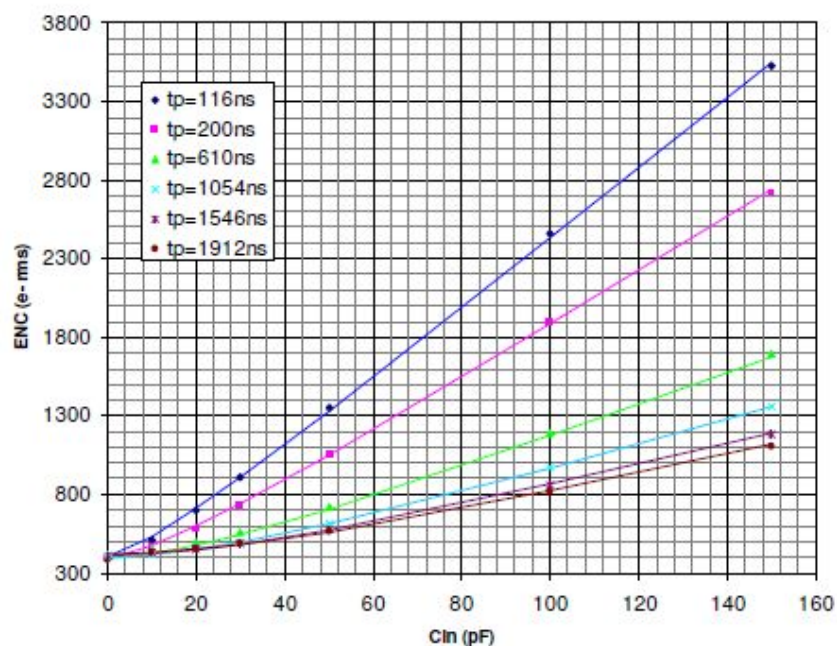
Calibration  
Procedure with  
Test pulses  
of 50 fC



### T2K noise measured @ Saclay



Due to strips and coupled  
capacitance we can expect  
a 400 e<sup>-</sup> noise at all the  
peaking times



Test of One AFTER Chip which is wasn't  
connected to the detector and has 8  
channels disconnected (the first and the  
last 4).

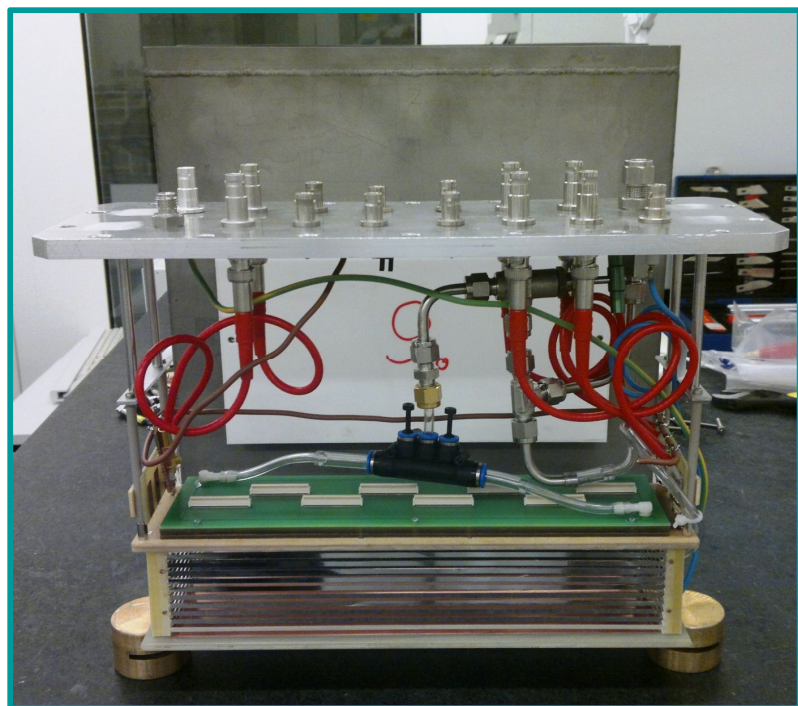
There is a fixed pattern with 4 noisy  
channels.

Related to the signal amplitude 1 ADC  
count correspond to 0.12 fC or 700 e<sup>-</sup>

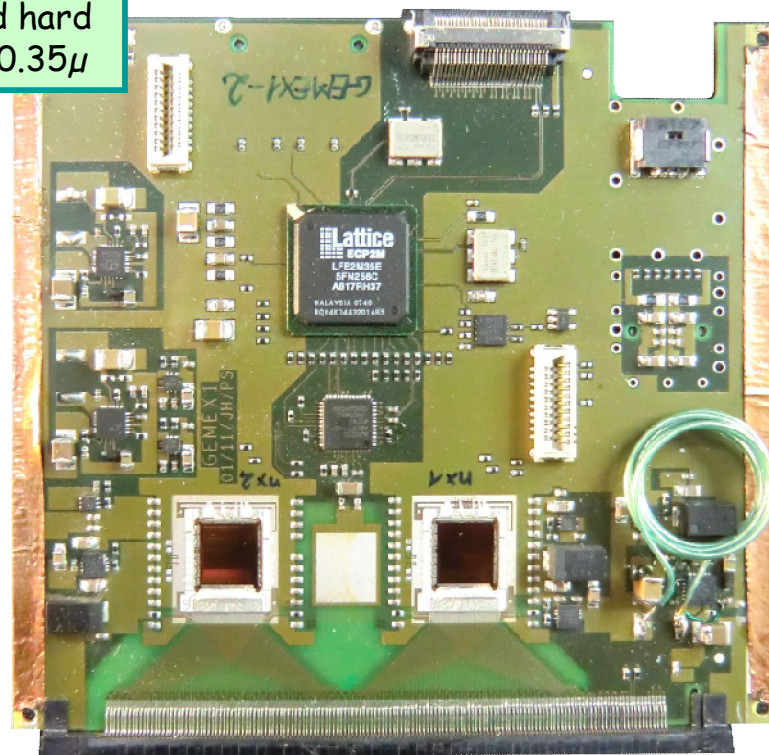


# STATUS OF THE PROTOTYPE HB3(cont.)

## GEM-TPC Readout Electronics and DAQ.

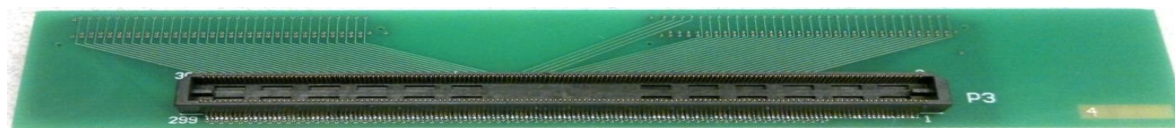
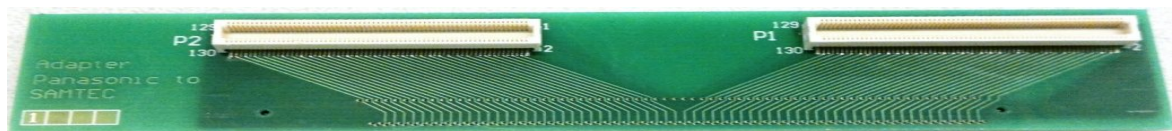


n-XYTER,  
non rad hard  
AMS 0.35 $\mu$



Provide by the Detector  
Laboratory @ GSI  
Bern Voss

## PAN to SAMTEC Adapter

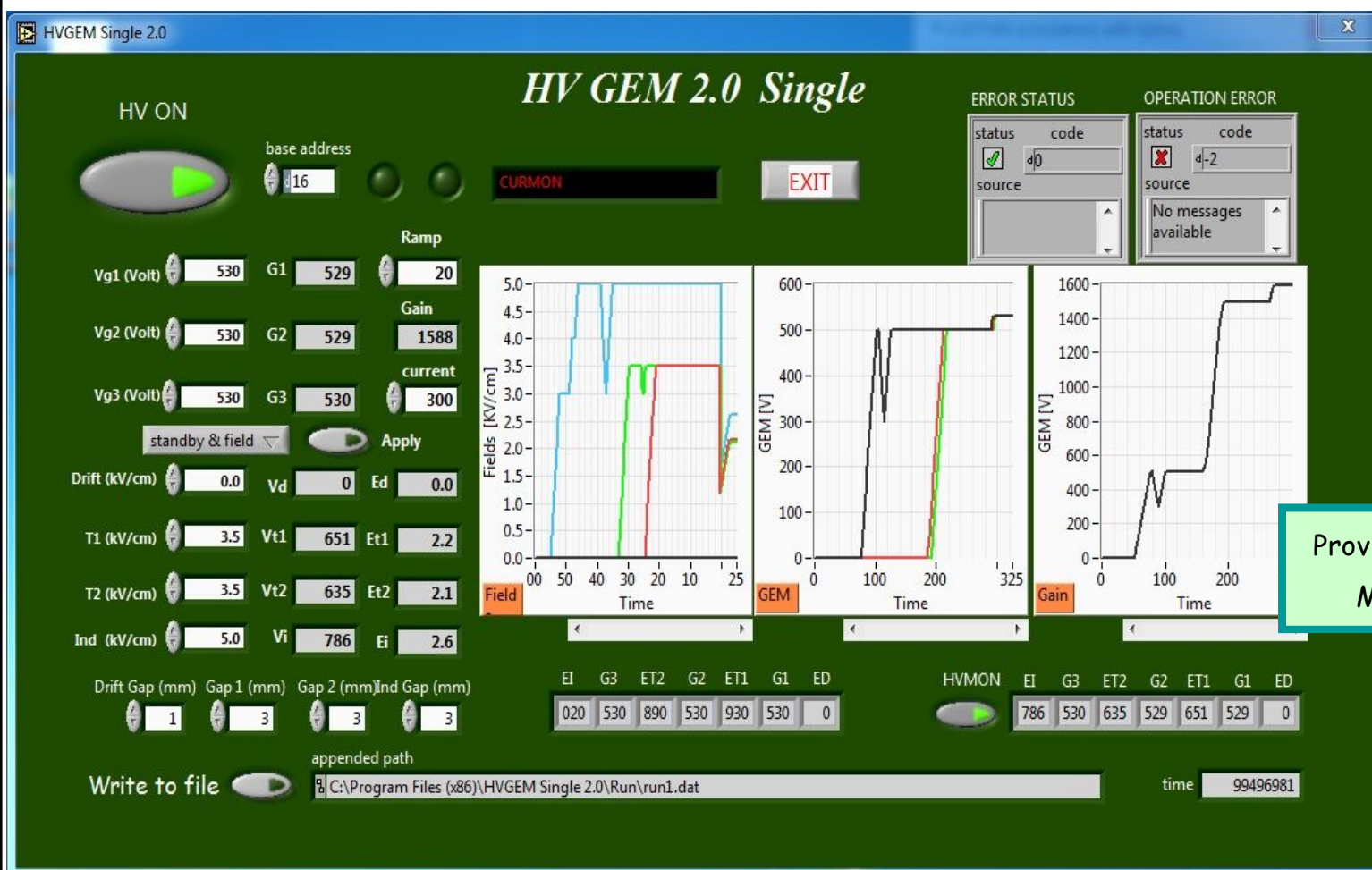


At the top a Samptec connector 300 pins and in the left side two Panasonic connectors of 130 pins each



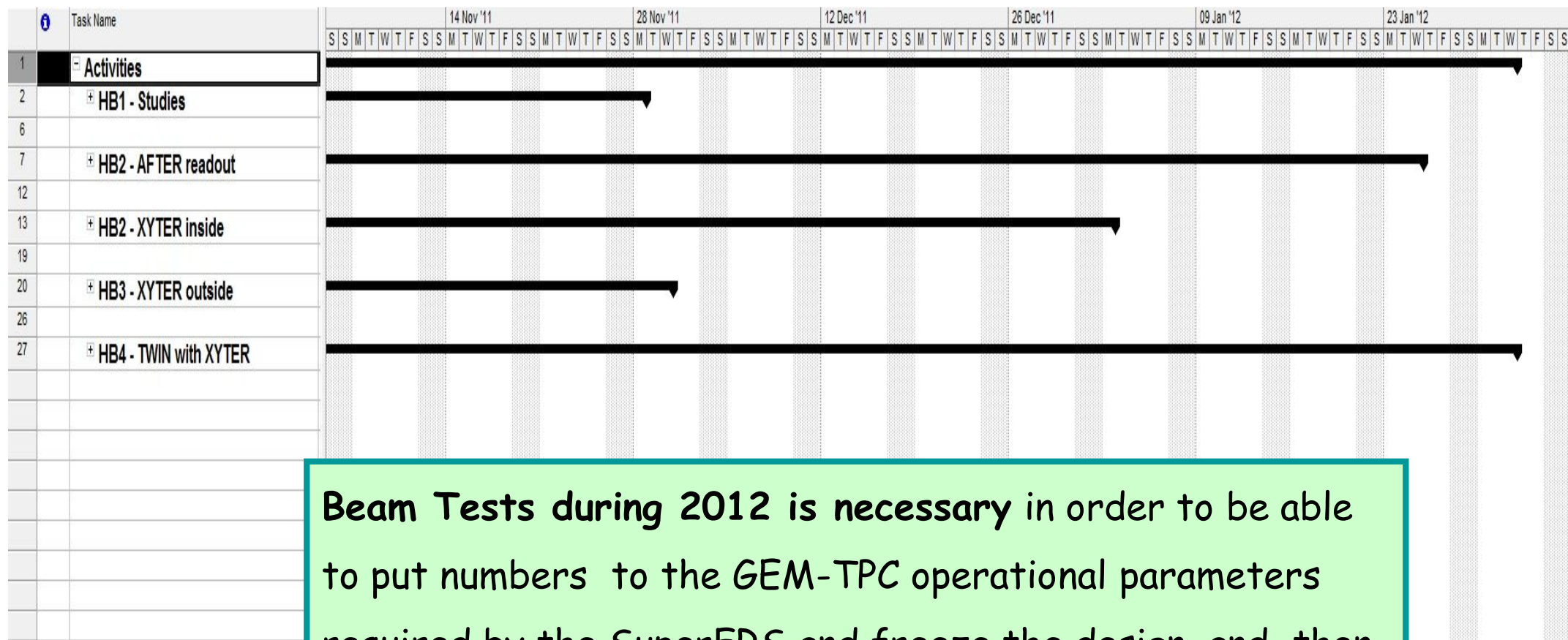
## ACTIVE DIVIDER FOR GEM-TPC

Active Divider for the GEM Stack



**All Channels with current limit:**  
In the range from 10nA up to 6 $\mu$ A  
with a resolution of 40 nA

## TASK SCHEDULE for 2012



Beam Tests during 2012 is necessary in order to be able to put numbers to the GEM-TPC operational parameters required by the SuperFRS and freeze the design, and then kick-off mass production



## TODO

- Production of a flange for the HB2 with AFTER readout and prepare the DAQ
- Production of a Flange for the nXyter readout of the HB3
- Participate in the Beam campaigns of GPAC at GSI and at Jyväskylä
- Get some simulations results in order to carry out some optimizations
- Design of the components for the Twin GEM-TPC i.e. GEM foils masks, frames, drift foils and flange